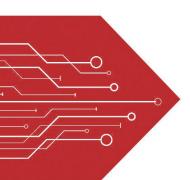
## MSKSEMI















**ESD** 

TVS

TSS

MOV

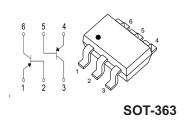
**GDT** 

**PLED** 

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#### **DUAL TRANSISTOR (PNP+PNP)**

#### **FEATURES**

- Two transistors in one package
- Reduces number of components and board space
- No mutual interference between the transistors

**MARKING: 5Ft** 

#### MAXIMUM RATINGS (T<sub>a</sub>=25℃ unless otherwise noted)

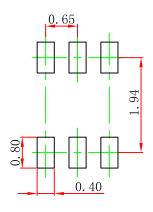
Symbol	Parameter	Value	Units
V <sub>CBO</sub>	Collector- Base Voltage	-80	V
V <sub>CEO</sub>	Collector-Emitter Voltage	-65	V
V <sub>EBO</sub>	Emitter-Base Voltage	-5	V
Ic	Collector Current -Continuous	-0.1	Α
Pc	Collector Power Dissipation	0.2	W
Reja	Thermal Resistance from Junction to Ambient	625	°C/W
TJ	Junction Temperature	150	$^{\circ}$
T <sub>stg</sub>	Storage Temperature	-55-150	°C

## **ELECTRICAL CHARACTERISTICS PNP 5401 (Ta=25℃ unless otherwise specified)**

Parameter	Symbol	Test conditions	Min	Тур	Max	Unit
Collector-base breakdown voltage	V <sub>(BR)CBO</sub>	I <sub>C</sub> =-10μA,I <sub>E</sub> =0	-80			V
Collector-emitter breakdown voltage	V <sub>(BR)CEO</sub>	I <sub>C</sub> =-10mA,I <sub>B</sub> =0	-65			V
Emitter-base breakdown voltage	V <sub>(BR)EBO</sub>	ο I <sub>E</sub> =-10μΑ,I <sub>C</sub> =0				V
Collector cut-off current	I <sub>CBO</sub>	V <sub>CB</sub> =-30V,I <sub>E</sub> =0			-15	nA
Emitter cut-off current	I <sub>EBO</sub>	V <sub>EB</sub> =-5V,I <sub>C</sub> =0			-100	nA
DC current gain	h <sub>FE</sub>	$V_{CE}$ =-5 $V$ , $I_{C}$ =-2 $mA$	110		600	
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	I <sub>C</sub> =-10mA, I <sub>B</sub> =-0.5mA			-0.1	V
Conector-ennitier saturation voltage		I <sub>C</sub> =-100mA, I <sub>B</sub> =-5mA *			-0.3	V
Base-emitter saturation voltage	V <sub>BE(sat)</sub>	I <sub>C</sub> =-10mA, I <sub>B</sub> =-0.5mA		0.7		V
Output Capacitance Co		V <sub>CB</sub> =-10V, f= 1MHz, I <sub>E</sub> = 0			2.5	pF
Current Gain-Bandwidth Product		V <sub>CE</sub> =-5V, I <sub>C</sub> =-10mA, f= 100MHz	100			MHz

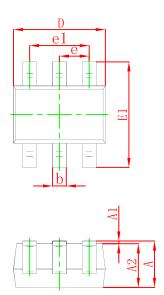
<sup>\*</sup>pulse test: PW≤350μS, δ≤2%.

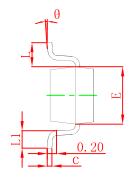
#### SOT-363



#### Note:

- 1.Controlling dimension:in millimeters. 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.





Symbol	Dimensions In Millimeters		Dimensions In Inches		
Syllibol	Min	Max	Min	Max	
Α	0.900	1.100	0.035	0.043	
A1	0.000	0.100	0.000	0.004	
A2	0.900	1.000	0.035	0.039	
b	0.150	0.350	0.006	0.014	
С	0.100	0.150	0.004	0.006	
D	2.000	2.200	0.079	0.087	
Е	1.150	1.350	0.045	0.053	
E1	2.150	2.400	0.085	0.094	
е	0.650 TYP		0.026 TYP		
e1	1.200	1.400	0.047	0.055	
L	0.525 REF		0.021 REF		
L1	0.260	0.460	0.010	0.018	
θ	0°	8°	0°	8°	

## **REEL SPECIFICATION**

P/N	PKG	QTY
BC856S	SOT-363	3000



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